

<b>Notice of References Cited</b>	Application/Control No. 09/542,670	Applicant(s)/Patent Under Reexamination URICH ET AL.	
	Examiner Victor X Nguyen	Art Unit 3731	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,027,515	02-2000	Cimino, William W.	606/169
	B	US-5,897,569	04-1999	Kellogg et al.	606/169
	C	US-6,258,111	07-2001	Ross et al.	606/171
	D	US-4,024,866	05-1977	Wallach, Mark	604/31
	E	US-5,425,704	06-1995	Sakurai et al.	604/22
	F	US-4,911,161	03-1990	Schechter, Alan M.	606/107
	G	US-6,165,190	12-2000	Nguyen, Nhan	606/166
	H	US-6,261,297	07-2001	Kadziauskas et al.	606/107
	I	US-5,383,460	01-1995	Jang et al.	600/439
	J	US-3,673,475	06-1972	Britton, Jr., Ralph H.	318/122
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.